Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/802,650	TABATA, YUTAKA	
Examiner	Art Unit	
Anthony Weier	1761	

	SEAR	CHED	
Class	Subclass	Date	Examiner
426	518, 481, 482, 444,478		
	632	3/28/2007	AW
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			-

SEAR (INCLUDING SI	CH NOT	ES STRATEGY	)
		DATE	EXMR
Inventor Search		3/28/2007	AW